

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>	ATTORNEY DOCKET NO. 1572.1210	APPLICATION NO. TO BE ASSIGNED
	FIRST NAMED INVENTOR Won-jun KOH et al.	
	FILING DATE November 14, 2003	GROUP ART UNIT TO BE ASSIGNED

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
AB	AA	5,157,319	10/20/92	Klontz et al.			
AB	AB	5,341,083	8/23/94	Klontz et al.			
AB	AC	5,568,036	10/22/96	Hulsey et al.			
AB	AD	6,184,651	2/6/01	Fernandez et al.			

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION	
							YES	NO
AB	AE	85-2830	5/30/85	Republic of Korea				X
AB	AF	96-6459	2/17/96	Republic of Korea				X
AB	AG	97-3399	1/24/97	Republic of Korea				X
AB	AH	2002-57468	7/11/02	Republic of Korea				X
AB	AI	2002-57469	7/11/02	Republic of Korea				X
AB	AK	10-363439	12/5/02	Republic of Korea				X
AB	AL	10-375757	3/15/03	Republic of Korea				X
AB	AM	7-212887	8/11/95	Japan			Abstract	
AB	AN	8-18636	1/19/96	Japan				X
AB	AO	2002-199598	7/12/02	Japan			Abstract	

OTHER REFERENCES (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

	AP	
	AQ	

EXAMINER /Alexis Boateng/	DATE CONSIDERED 08/21/2006
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

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